

Notice of References Cited

Application/Control No.

09/945,508

Applicant(s)/Patent Under
Reexamination
KO, KEI-YU

Examiner

Lynette T. Umez-Eronini

Art Unit

1765

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5828096	10-1998	Ohno et al.	257/306
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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